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Fabricating Nanogaps in YBa$_2$Cu$_3$O$_{7-\delta}$ for Hybrid Proximity-Based Josephson Junctions

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The advances of nanotechnologies applied to high-critical-temperature superconductors (HTSs) have recently given a huge boost to the field, opening new perspectives for their integration in hybrid devices. The feasibility of this research goes through the realization of HTS nanogaps with superconductive properties close to the as-grown bulk material at the nanoscale. Here we present a fabrication approach allowing the realization of YBa$_2$Cu$_3$O$_{7-\delta}$ (YBCO) nanogaps with dimensions as small as 35 nm. To assess the quality of the nanogaps, we measure, before and after an ozone treatment, the current-voltage characteristics and the resistance versus temperature of YBCO nanowires with various widths and lengths, fabricated by using different lithographic processes. The analysis of the superconducting transition with a thermally activated vortex-entry model allows us to determine the maximum damage the nanowires undergo during the patterning which relates to the upper bound for the dimension of the nanogap. We find that the effective width of the nanogap is of the order of 100 nm at the superconducting transition temperature while retaining the geometrical value of about 35 nm at lower temperatures. The feasibility of the nanogaps for hybrid Josephson devices is demonstrated by bridging them with thin Au films. We detect a Josephson coupling up to 85 K with an almost ideal magnetic-field response of the Josephson current. These results pave the way for the realization of complex hybrid devices, where tiny HTS nanogaps can be instrumental to study the Josephson effect through barriers such as topological insulators or graphene.

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I. INTRODUCTION

In recent years, the advances of nanotechnologies applied to high-critical-temperature superconductors (HTSs) have been such that the long-sought integration with semiconductor films or nanowires, organic electronic materials, and, more recently, materials characterized by a Dirac dispersion relation is slowly becoming a reality. Hybrid devices involving interfaces between HTSs and, for example, topological insulators (TIs) or graphene are extremely promising to reveal the new physics due to the proximity of a superconductor and a two-dimensional material with a Dirac cone [1–3]. There are several theoretical reports, which refer to the d-wave symmetry of the order parameter in HTSs and to the large value of the superconducting gap, to design experiments to stabilize and reveal the existence of Majorana fermions, still elusive particles in solid-state systems, that are supposed to nucleate at the interface between a superconductor and a TI [4–8]. Superconducting hybrid structures are also considered a crucial step towards a topological quantum computer, which would be exceptionally well protected from errors, thanks to the non-Abelian statistics of Majorana fermions [9,10].

At the same time, by interfacing HTS nanogaps with graphene, one could get access to the quantum Hall effect in a regime of Josephson transport, made possible by the extremely high upper critical field of the HTS (of the order of 100 T) and superconducting gap. Fascinating physics aspects are expected to emerge from the transport of coherent Cooper pairs through opposite edge states in the quantum Hall regime. In particular, here Cooper pair transport could also play an important role in stabilizing even further the already robust quantum Hall plateaus in graphene [11–13].

The realization of HTS hybrid devices requires the engineering of reproducible and stable nanogaps, which is a challenging task because of the surface and chemical instability of thin films. In this paper, we present an approach that allows obtaining YBa$_2$Cu$_3$O$_{7-\delta}$ (YBCO) planar nanogaps below 40 nm. This has been achieved by protecting the sides of the electrodes with a Pt/Au bilayer during subsequent e-beam lithography steps and by using a soft (low-temperature) resist baking. In future hybrid devices, the superconducting proximity will then be induced through the noble metal layer that has to be thin enough to take advantage of the large HTS...
superconducting gap. The aim of this work is twofold: (a) to get proper estimates for the effective size of the HTS nanogaps, representing the ultimate channel length in hybrid structures, and (b) to show the feasibility of the YBCO nanogaps to induce a proximity Josephson coupling when bridged with a conventional normal metal [14]. This is a crucial step for interfacing with more complex materials. In particular, we show that the Au/YBCO interface involved in the Josephson tunneling is close to the optimal doped regime, which is of high relevance to achieve high Josephson current values.

Previous attempts to realize superconductor–normal-metal–superconductor (S-N-S) junctions with YBCO nanogaps used the possibility of breaking the continuity of YBCO films when grown on trenches or steps fabricated in the substrate. In pioneering works, trenches of YBCO films when grown on trenches or steps nanogaps used the possibility of breaking the continuity is close to the optimal doped regime, which is of high metal to realize $S$–$N$–$S$ links, mimicking the Josephson behavior of the final structure. These techniques rely on the deposition of an in situ Au/Ag film, acting as a normal barrier to realize the $S$–$N$–$S$ junction, in order to minimize the contact resistance between the YBCO and the normal metal. Furthermore, these approaches suffer from the random formation of YBCO grain boundaries at the edges of the trenches or steps. They would act as weak links, mimicking the Josephson behavior of the final $S$–$N$–$S$ structure. These techniques rely on the deposition of an in situ Au/Ag film, acting as a normal barrier to realize the $S$–$N$–$S$ junction, in order to minimize the contact resistance between the YBCO and the normal metal. Furthermore, these approaches seem to be incompatible for interfacing of YBCO electrodes with materials other than Au/Ag such as TIs, graphene, or even organic conductors. Attempts to obtain planar YBCO nanogaps, by a direct patterning of YBCO with FIB [21,22] or Ar$^+$ ion milling [23], followed by a deposition of a normal metal to realize $S$–$N$–$S$ junctions, do not have follow-up results. But, more importantly, the poor reproducibility of the various techniques remains an unresolved issue.

Here we show that highly reproducible planar YBCO nanogaps can be obtained by the complete Au “encapsulation” of the electrodes, forming the nanogap. This is essential to limit the extension of the damaged area on the inner sides of the YBCO nanogap, minimizing the effective length of the nanochannel. In general, to interface YBCO nanogaps with graphene, Ti flakes, or nanowires, two $e$-beam lithography (EBL) steps would, in principle, be sufficient to define hybrid nanostructure: the first EBL to pattern YBCO nanogaps, and the second one to contact the flakes or nanowires once they have been transferred on the substrate. However, since YBCO easily degrades by getting in contact with chemicals such as $e$-beam resists, the second lithography steps would seriously enlarge the effective width of the nanogap, making the observation of the superconducting proximity effect very critical. For YBCO hybrid devices, before the transferring of the flake or nanowire, the sides of patterned YBCO need to be protected with a noble-metal layer. This implies further extremely challenging $e$-beam lithography for reopening the nanogap by removing the new Au layer deposited across it.

To assess the extension of the damaged regions of the YBCO electrodes and therefore the effective length of the channel, we focus on the study of the superconducting transport properties of a “prototype” for the realization of HTS nanogaps: a YBCO nanowire capped with a thin Au layer (20 nm).

The main idea is to study the regime of fluctuations in superconducting nanowires (with the top and sides covered by a Pt/Au bilayer in analogy with the nanogaps), which undergoes the same processing steps as the ultimate YBCO nanogaps. From the analysis of the resistance versus temperature $R(T)$ data, we can extract the upper limit for the damaged regions, which is discussed in more detail further on in the text. This is also fundamental to understand the Josephson properties of the junctions obtained by bridging the nanogap with a normal metal.

II. DEVICE FABRICATION

For the realization of the devices, a 50-nm-thick YBCO film is deposited on a MgO (1 1 0) substrate, suitable for high-frequency characterization [24], using pulsed laser deposition (PLD). The deposition conditions (e.g., substrate temperature, background oxygen pressure, laser energy, and cooling-down rate) are optimized to achieve high-quality, epitaxial $c$-axis-oriented YBCO films with a smooth surface with roughness less than 1.5 nm. All YBCO films exhibit a critical temperature ($T_c$) between 85 and 86 K with a 1-K-wide resistive transition. Structural characterization [25] allows us to establish that the starting films are in the overdoped region of the superconducting dome. The YBCO film is then in situ covered with a 20-nm-thick Au film. Then, a 70-nm-thick layer of diamondlike carbon (DLC), acting as a hard mask during the ion milling of the YBCO nanogap, is deposited by PLD [26]. Because of its extremely low Ar$^+$ etching rate, the thin layer of DLC film is an excellent masking material for realizing sub-100-nm features [27].

The fabrication process is schematically depicted in Figs. 1(a)–1(h). It involves three EBL steps. First, we fabricate the nanowires and the current probes by following the procedure described in Refs. [26,28] [whose result is schematically illustrated in Fig. 1(a)]. Then, a bilayer of Pt (10 nm)/Au (50 nm) is deposited on the entire chip including the side walls of YBCO structures [Fig. 1(b)]. A second EBL procedure is used to finalize the
encapsulation of the nanostructures [Figs. 1(c)–1(h)]. The transferred pattern is slightly larger (30–50 nm) with respect to the already-patterned nanowire layout. This is done to ensure that all the YBCO edges remain protected by Pt/Au after the ion milling of the Au [Fig. 1(h)]. Also in this case DLC is used as an etching mask. The third and last EBL step is performed to define the narrow voltage probes. With this type of electrode configuration, the temperature dependence of the resistive transition involves only the narrow nanowire and not the transition of the wide electrodes. A SEM image of the typical 3EBL device is shown in Fig. 1(i).

For comparison, we also fabricate YBCO nanowires covered with a thin Au film with a single and two EBL steps. In the first case, nanowires capped with Au are used as reference systems concerning the best superconductive properties one can achieve in a YBCO nanostructure under specific oxygen-doping conditions. They are referred to as 1EBL devices throughout this paper. In the latter case, instead the two lithography steps refer to the patterning of the nanowire capped with Au and to another processing for connecting the nanowire to the outer bonding pads by a lift-off procedure. In this case, the edges of the nanowire are unprotected and in direct contact with the resist and other chemicals during the second lithography step. These nanostructures are addressed as 2EBL devices. More details about the fabrication of 2EBL devices can be found in Supplemental Material [30].

III. TRANSPORT PROPERTIES OF NANOWIRES PATTERNED WITH DIFFERENT PROCEDURES

A. Study of the critical current $J_C$ as a function of the nanowire width and length

We systematically study the transport properties of YBCO nanowires as a function of widths and lengths in the range of 60–700 nm and 1–10 μm, respectively, for 1EBL, 2EBL, and 3EBL devices. The measurements are performed in a $^3$He cryostat with a base temperature of 300 mK. The current-voltage characteristics (IVCs) are measured by sweeping the current and measuring the voltage across the wire. The critical current density $J_C$ for all devices is extracted and plotted in Fig. 2. The maximum critical current density of $6.1 \times 10^7$ A/cm$^2$ is achieved for a 200-nm-wide and 1-μm-long nanowire processed with one EBL step (Fig. 2, red circles). Compared to our recent study [29], we do not observe the highest $J_C$ for the narrowest wire. This is a consequence of the very thin Au (20 nm) capping layer we use for protection. In our previous report [29], we have shown that 50 nm is the minimum thickness of the Au capping required to preserve the pristine superconducting properties of the nanostructures. As also reported in other works, the decrease of the $J_C$ for width below 200 nm could result from a partial degradation of YBCO nanostructure during the patterning [31–33]. Our choice to minimize the thickness of the Au layer is dictated by the final goal to realize superconducting hybrid devices. Since in these structures...
the proximity will be induced through the Au layer, thinner thicknesses are able to warrant a stronger superconducting proximity. For the 1EBL samples, the decrease of $J_C$ by increasing the nanowire width (above 200 nm) can be ascribed to current crowding effects \cite{28}. It is also evident that for 1EBL the maximum $J_C$ value is reduced for a longer length of nanowires (dark red crosses, pink diamonds) and is almost independent of the nanostructure width above 200 nm. At such extended lengths, it is possible that inhomogeneities in the film, rather than current crowding, have a major effect on the value of $J_C$. This would naturally explain the almost-constant value of $J_C$ as a function of the width for the longest nanowires. Below 200-nm width, also in these cases the $J_C$ decreases by reducing the width as a result of degradation of the superconducting properties at the smallest width. It is worth mentioning that all the data for 1EBL refer to nanowires patterned on the same chip and that therefore are not influenced by the possible random variations due to film quality or nanopatterning procedure that can affect nanostructures fabricated on different chips.

The same $J_C$ trend is also observed for 3EBL devices (see Fig. 2: blue squares, light blue triangles, and cyan stars). In this case, the maximum value of $4.5 \times 10^7$ A/cm$^2$ is achieved for a 150-nm-wide and 1-$\mu$m-long nanowire and is only about 20% lower than the values obtained for 1EBL. This confirms that the superconducting properties of the YBCO nanowires are well preserved even though the nanostructure is undergoing several lithographic procedures.

In contrast to 1EBL and 3EBL, the 2EBL devices show a significant reduction in the $J_C$ values for nanowires with the shortest length (1 $\mu$m). The fact that we observe such a huge reduction of the $J_C$ is that the resist and chemicals, in general, are in direct contact with the YBCO edges of the patterned nanowire during the fabrication, which has an adverse effect on the superconducting properties of the nanostructure. Moreover, the 2EBL devices do not show any superconducting transition for the widths below 400 nm. This means that the damaged nonsuperconducting region extends approximately for about 200 nm from both lateral sides of the nanowire. YBCO nanogaps, fabricated by using a 2EBL procedure, would have an effective width 400 nm larger than the geometrical-nominal one, which would make the observation of proximity-induced superconductivity very hard to detect \cite{34}.

B. Analysis of the resistance versus temperature transition

As a further characterization of the nanowires fabricated with different procedures, we measure the resistance versus temperature $R(T)$ of 1EBL and 3EBL devices. Figure 3 shows the superconducting transition of both 1EBL and 3EBL devices of comparable widths. The curves are characterized by a broadening, which is larger in 3EBL devices. Such a broadening, expected in nanowires with width $w$ much larger than the coherence length $\xi$ [$w \gg 4.4\xi(T)$ even at $T \approx T_C$], can be ascribed to the dissipation induced by vortices, perpendicular to the bias current, crossing the nanowire \cite{35–38}. The resistance of 1EBL and 3EBL nanowires can be written as

$$R(T) = [R_v^{-1}(T) + R_{sh}^{-1}]^{-1},$$

where $R_{sh}$ is the shunt resistance associated with the gold layer, corresponding to the resistance value measured at the onset of the superconducting transition, and $R_v$ is the thermally activated vortex-entry resistance, which can be expressed as

$$R_v(T) = \lambda_0 \left( \frac{T}{T_C} \right)^{1/2} \exp \left( \frac{\Phi_0}{2 k_B T} \right)\exp \left( \frac{\Phi_0}{2 k_B T} \right),$$

where $\Phi_0$ is the flux quantum, $k_B$ is the Boltzmann constant, and $T_C$ is the critical temperature.

FIG. 2. Critical current density $J_C$ versus width $w$ for 1EBL, 2EBL, and 3EBL nanowires with different lengths.

FIG. 3. Resistance versus temperature of a 1EBL nanowire (triangles) and of a 3EBL nanowire (circles), having the same length and similar width. The lines are the fits to the two data sets, using a thermally activated vortex-entry model. As a consequence of local inhomogeneities introduced by the nanopatterning procedure and of the oxygen out-diffusion, we have to consider a discrepancy between the geometrical and effective widths, of 25 and 35 nm per edge for 1EBL and 3EBL devices, respectively. This allows a good fit of the data using the typical values of $\lambda_0$ and $\xi_0$ for YBCO thin films and the same $T_C$ for both wires.
\[ R_v(T) = 7.1 R_\square \left( \frac{4l_\square \xi(T)}{(w_b + w_t)^2} \right) \left( \frac{\epsilon_0(T)}{k_BT} \right)^{3/2} \exp \left( -\frac{U_{\text{max}}(T)}{k_BT} \right), \]

with

\[ U_{\text{max}}(T) = \epsilon_0(T) \left( \frac{w_b \ln \frac{l_\square + \xi(T)}{\pi \mu_0} - w_t \ln \frac{l_\square + \xi(T)}{\pi \mu_0}}{w_b - w_t} - 1 \right). \]

In Eqs. (2) and (3), \( R_\square \) and \( l \) are, respectively, the sheet resistance and the length of the wire, \( k \) is the Boltzmann constant, and \( \epsilon_0(T) = \Phi_0^2 T / 4 \pi \mu_0 \lambda^2(T) \) is the characteristic energy of a vortex in thin films, with \( \Phi_0 = \hbar / 2e \) the superconducting flux quantum and \( \mu_0 \) the vacuum permeability. The temperature dependence of the London penetration depth and of the coherence length are given by \( \lambda_{\perp}(T) = \lambda_0 [1 - (T/T_C)^2]^{-1/2} \) and \( \xi(T) = \xi_0 [1 - (T/T_C)^2]^{-1/2} \), where \( \lambda_0 \) and \( \xi_0 \) represent the zero-temperature values. Equations (2) and (3) refine the expression we have previously considered in Refs. [25,37], since it takes into consideration that the cross section of our nanowires is trapezoidal (hence the top width \( w_t \) differs from the bottom width \( w_b \)).

According to Eq. (2), the superconducting transition becomes broader when decreasing the wire width \( w \) and thickness \( t \). In previous reports [37,39], we show that in YBCO nanowires protected by a 50-nm-thick Au layer the broadening at the transition can be fitted with Eqs. (1) and (2) considering the geometrical nanowire dimensions. The extracted values for \( \lambda_0 \) (approximately 270 nm) and \( \xi_0 \) (approximately 2.5 nm) are typical for YBCO thin films [40,41]. For the devices shown in Fig. 3, as a consequence of the very thin capping Au layer used in this work, the superconducting transition can be still very well fitted with Eq. (1) but only by assuming for the 1EBL nanowires approximately 25 nm of damage on both lateral sides, i.e., an effective width \( w_{\text{eff}} \) smaller than the geometrical one.

This is obtained while keeping the typical values for \( \lambda_0 \) (approximately 270 nm) and \( \xi_0 \) (approximately 2.5 nm).

The 3EBL devices have instead a larger broadening compared to 1EBL nanowires even for equal cross sections. Such broadening can again be nicely fitted by means of Eqs. (1) and (2), using a slightly larger damage of about 35 nm for each side (also in this case fixing \( \lambda_0 = 270 \text{ nm} \) and \( \xi_0 = 2.5 \text{ nm} \)). Such a variation with respect to 1EBL “reference” devices can be explained by considering that local inhomogeneities and oxygen out-diffusion become more relevant as a consequence of multiple lithographic procedures.

Here it is worth pointing out that the \( w_{\text{eff}} \) we extract from the \( R(T) \) fitting should be considered as a measure of the uniformity of the superconducting properties within 1–2 K from the critical-temperature onset. More specifically, the “damaged” area is caused by nonstoichiometric or oxygen-depleted paths, with a possible weakened superconductivity (and therefore a lower \( T_C \) onset below the one of the observed superconducting transition), that do not contribute to the fluctuation regime determining the broadening of the \( R(T) \) transition. However, we believe that these paths contribute instead to the superconducting transport properties of the nanowire at lower temperatures even though with a possible reduced critical current density. To verify if this scenario is possible in our nanostructures, we calculate the critical current densities \( J_{\text{C}}^\text{eff} \) one would get from the measured critical currents and assuming the effective width \( w_{\text{eff}} \) extracted from the \( R(T) \) fitting. The values of \( J_{\text{C}}^\text{eff} \) at 300 mK are reported for several wires fabricated with 1EBL and 3EBL nanowires (see Table I). These values are about 50% larger than the theoretical depairing limit value \( J_{\text{dep}}^\text{GL} \approx 6 \times 10^7 \text{ A/cm}^2 \) one would get within the Ginzburg-Landau theory in the low-temperature limit (assuming \( \lambda_0 \approx 270 \text{ nm} \) and \( \xi_0 \approx 2.5 \text{ nm} \)) [42]. If the \( J_{\text{C}} \) is limited by vortex entry, the maximum value a nanowire with \( w \approx 4.4 \xi \) can carry is predicted to be very close to \( J_{\text{dep}}^\text{GL} \) [36]. Whatever mechanism is determining the maximum \( J_{\text{C}} \), we conclude that the \( w_{\text{eff}} \) at 300 mK has to be

<table>
<thead>
<tr>
<th>Device</th>
<th>( J_{\text{C}} = (I_{\text{C}}/wT) ) (( \text{A/cm}^2 ))</th>
<th>( J_{\text{C}}^\text{eff} = (I_{\text{C}}/w_{\text{eff}}T) ) (( \text{A/cm}^2 ))</th>
</tr>
</thead>
<tbody>
<tr>
<td>1EBL ( w = 90 \text{ nm} )</td>
<td>( 3.84 \times 10^7 )</td>
<td>( 8.64 \times 10^7 )</td>
</tr>
<tr>
<td>1EBL ( w = 120 \text{ nm} )</td>
<td>( 5.62 \times 10^7 )</td>
<td>( 9.63 \times 10^7 )</td>
</tr>
<tr>
<td>1EBL ( w = 150 \text{ nm} )</td>
<td>( 5.84 \times 10^7 )</td>
<td>( 8.76 \times 10^7 )</td>
</tr>
<tr>
<td>1EBL ( w = 200 \text{ nm} )</td>
<td>( 6.20 \times 10^7 )</td>
<td>( 8.27 \times 10^7 )</td>
</tr>
<tr>
<td>3EBL ( w = 120 \text{ nm} )</td>
<td>( 3.88 \times 10^7 )</td>
<td>( 9.31 \times 10^7 )</td>
</tr>
<tr>
<td>3EBL ( w = 150 \text{ nm} )</td>
<td>( 4.41 \times 10^7 )</td>
<td>( 8.27 \times 10^7 )</td>
</tr>
<tr>
<td>3EBL ( w = 200 \text{ nm} )</td>
<td>( 4.32 \times 10^7 )</td>
<td>( 6.65 \times 10^7 )</td>
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substantially larger than the value extracted close to \( T \approx T_C \), and therefore the damaged regions on the side of the wires do contribute to the superconducting transport at lower temperatures.

**C. Comparison of the nanowire transport properties before and after ozonation**

To assess the relevance of oxygen out-diffusion during the nanopatterning of YBCO films, the ion milling, and the resist baking and to possibly “cure” our devices by proper reoxygenation, we develop an *ex situ* ozone treatment [25]. The ozone treatment has been already intensively used for decades in order to improve the superconducting properties of YBCO thin films and nanostructures [43,44]. In our case, the samples are placed in a chamber at atmospheric pressure, in which ozone is produced by the absorption in oxygen atoms of 185 and 254 nm ultraviolet light. In such an environment, the samples are kept for 2 h at 150°C and then slowly cooled down.

We study the effect of the ozone on 1EBL nanowires, as a function of both the wire width and length. Figure 4 summarizes the main results. For the 1-μm-long nanowires, characterized by very high critical current densities (though lower than the depairing limit for narrowest widths), a \( J_C \) enhancement in the range 15%–20% is clearly visible for all the widths [see Fig. 4(a), which shows data of nanowires all realized on the same chip before and after ozone treatment]. As a consequence of the ozone annealing, the YBCO nanowires improve their superconducting properties, reaching \( J_C \) values very close to the depairing limit [28,29] or higher [45]. As a further confirmation of the high degree of homogeneity acquired by the nanowires after the ozonation, we have also shown in Ref. [25] that the superconducting transition of the ozonized nanowires is characterized by a smaller broadening, which can be fitted by means of Eqs. (1) and (2) without assuming any damage on the sides. However, the effect of ozone becomes much more prominent in the longest nanowires. For these devices, presenting a substantial reduction of the \( J_C \), as shown in Fig. 2 (pink diamonds), the increase of critical current after the ozonation can be up to 200%, as shown in Fig. 4(b). The validity of this treatment in supplying oxygen to the nanostructure, out-diffused during the nanopatterning procedure, is confirmed by the reduction of the critical temperature \( T_C \) after ozonation [see the inset in Fig. 4(b)], which is strictly related to a variation of the oxygen doping inside the nanostructures toward the overdoped region of the YBCO phase diagram [25]. Moreover, in very long and narrow 1EBL nanowires, the superconducting transition is not only quite broad, but it also presents a bump, which is a clear footprint of deoxygenated regions, with a lower critical temperature, having the size of the entire wire cross section [see the inset in Fig. 4(b)]. In such cases, the ozonation procedure makes the transition narrower, dissolving the bump and making the nanostructure more homogeneous.

The 3EBL nanowires could, in principle, benefit in the same way from the ozone annealing. However, the ozonation can act differently depending on whether it is performed after the first or the third lithographic step. As we show in a previous work [25], the oxygen refilling obtained with the ozonation mainly occurs through the lateral sides of the nanowires, since the oxygen mobility is much higher in the \( a-b \) planes than along the \( c \)-axis direction [44,48]. To observe in 3EBL nanowires the same effect observed in very long 1EBL ones [see Fig. 4(b)], the ozonation has to be performed after the first lithographic step, before the wire is encapsulated by the Pt/Au layer, since the protecting layer acts as a barrier for the oxygen to diffuse into the YBCO.

Here we discuss the consequence of the ozonation on already-encapsulated nanowires (3EBL). For such

![FIG. 4.](image-url)  
(a) Critical current densities \( J_C \) of 1-μm-long 1EBL nanowires, measured before and after the ozone treatment, as a function of the wire width. As a consequence of the ozonation, a \( J_C \) enhancement in the range 15%–20% is clearly visible for all the widths. (b) Current voltage characteristic of a 60-nm-wide and 10-μm-long 1EBL nanowire before and after ozone treatment. In the inset, the resistive transition of the same nanowire before and after ozonation is shown. The critical temperature decreases by more than 2.5 K as a consequence of the ozone treatment.
structures we observe a critical-temperature increase [Fig. 5(a)]. This can be simply explained by the fact that the encapsulation acts as a block for the oxygen, preventing it from entering into the nanostructure. At the same time, the broadening of the superconducting transition is slightly reduced, and it can be well fitted by considering the vortex-entry model and a damage region reduced by \(5\text{–}10\ \text{nm}\) for each of the edges of the nanowire compared to the situation before the ozonation [black lines in Fig. 5(a)]. To clarify the physical scenario, we study the IVCs of the 3EBL nanowires before and after ozonation. While the treatment does not increase the value of the critical current (in some cases the \(J_C\) is slightly reduced), it homogenizes the oxygen content within the encapsulated nanowire. As shown in Fig. 5(b) for a 90-nm-wide and \(10\ \mu\text{m}\)-long 3EBL nanowire: as a consequence of the ozonation, the wire, which was previously resistive, becomes superconducting. Hence, in 3EBL devices, the role of ozone is not to reoxygenate the structures but to redistribute the oxygen, healing the YBCO that was damaged by the nanopatterning procedure.

To study the electrical properties of our YBCO/AU interfaces, we realize a set of YBCO nanowires connected by one Au bar [see Figs. 6(a) and 6(b)]. The Au is removed from the top of the nanowires to get a well-defined contact geometry. From the point of view of the transport properties, the Au/YBCO interface is representative of those present in the nanogap. A typical conductance measurement as a function of the bias voltage is shown in Fig. 6(c) before and after ozonation. We clearly observe a tunnel-like conductance curve, after the ozonation, with the clear appearance of a gap structure at \(V \sim 50\ \text{mV}\) which is twice the value of the YBCO gap at the optimally doped regime. Here it is worth mentioning that the layout of the devices is such that we always measure two interfaces in series, which explains the doubling of the gap value in the conductance curve. Before the ozonation, instead, the curve has an anomalous voltage dependence [blue line in Fig. 6(c)] which could be fitted with \(V^\alpha\) with \(\alpha = 0.5\) in the low-bias regime [dotted yellow curve in Fig. 6(c)]. This kind of dependence has been previously observed in amorphous Ge\(_{1-x}\)-Au\(_x\) films [49] and attributed to the modification of the density of states of the compound in proximity of the metal-insulator transition. In our case, the total conductance is the contribution from both the top and side contact. In particular, the side interface undergoes an oxygen loss...
during the patterning of the nanowire which leads to a YBCO layer at the interface with strongly degraded superconducting properties possibly close to the metal-insulator transition. After the ozonation, the disappearance of the low-bias conductance anomaly and the occurrence of a gap feature in the conductance curve give a strong indication of a restored YBCO at the side interface. From the low-bias conductance values, we can estimate an average value for the contact resistivity of the YBCO/Au interface, from the top and side contact, of approximately $4 \times 10^{-8} \, \Omega \, \text{cm}^2$. This value is among the best reported in the literature [15,16,50], corroborating the potentiality of the nanogap for proximity hybrid devices, that we demonstrate in the next paragraph.

V. JOSEPHSON EFFECT THROUGH ENCAPSULATED NANOGAPS

Figure 7(a) shows an array of YBCO nanogaps fabricated by using a 3EBL procedure. Here the second lithography is used to remove the Pt/Au from the nanogaps while preserving the bilayer on the edge of the electrodes. The picture clearly shows well-defined nanogaps over several micron distances with a width below 40 nm. By considering that the maximum damage occurring to the electrodes is of the order of 30 nm (after the ozonation) close to $T_C$, the effective size of the nanogap is at most 100 nm at the transition temperature of the YBCO. At lower temperatures, instead we can expect that the extension of the nanogap is very close to 35 nm.

To probe the superconducting properties of the YBCO nanogaps, we bridge them with a thin Au film to realize a proximity-based $S$-$N$-$S$ Josephson junction. The devices fabricated by using this approach have a proximity coupling up to 85 K. Figure 7(b) shows an example of the IVC at 73 K. The curve can be well described by the resistively shunted junction model in the presence of thermal noise [51]. The dependence of the Josephson critical current as a function of the external magnetic field, applied in the plane of the junction, is shown in Fig. 7(c). The magnetic field pattern of the critical current is close to Fraunhofer-like with a modulation period $\Delta B \sim 1 \, \text{mT}$ [see Fig. 7(c)]. This value is in reasonable agreement with the predicted period [52] $\Delta B \sim 1.84 \Phi_0 / w_J^2$ for thin-film planar junctions with...
$w_j \sim 3 \mu m$ the width of the junction. The position of the first minimum, i.e., half the width of the main lobe, is larger than $\Delta B$. This can be understood from the fact that our junction is at the border of a short-to-long junction, $w_j \gtrsim l_J$, with $l_J = (\Phi_0/4\pi\mu_0\lambda J_C) \sim 1 \mu m$ the Josephson penetration depth for thin-film junctions [53]. Indeed, in this limit for small field values, the junction causes the critical current to decrease linearly with the applied field $I_C(B) = I_C(0)(1 - |B|/B_C)$ with $B_C > \Delta B$ [54,55].

The junction resistance is also nearly temperature independent, and for the sample of Fig. 7(b) it has a value $R_N$ of 1.5 $\Omega$. We characterize the transport properties of microbridges of Au of the same thickness used to encapsulate the electrodes and to bridge the nanogap. The resistivity of the Au bars is of the order of $1 \times 10^{-8}$ $\Omega m$ at 4.2 K, which gives a value for the resistance of the Au channel of about 7.5 m$\Omega$, much lower than the resistance $R_N$ of the junction. Therefore, we conclude that the value of $R_N$ is mostly due to the contact resistance YBCO/Au. Moreover, the rather high values for the critical current density $J_C$ we get at 77 K, $J_C(77 K) \sim (2-4) \times 10^4$ $A/cm^2$, and at 4.2 K, $J_C(4.2 K) \sim (1-2) \times 10^6$ $A/cm^2$, are due to the low value achieved for the YBCO/Au contact resistance $R_C$.

VI. SUMMARY AND CONCLUSIONS

In conclusion, we perform a systematic study on YBCO nanowires, having different widths (60–700 nm) and lengths (1–10 $\mu m$). The wires, realized through three $e$-beam lithographic steps, are protected by means of a Pt/Au bilayer, covering their sides. After the nanopatterning, an ex situ ozone annealing is applied to the nanostructures, in order to recover the possible oxygen out-diffused during the fabrication. We characterize the nanowires by $R(T)$ and $I/V C$ measurements, performed both before and after the ozonation. By comparing the superconducting properties of these nanowires with those of YBCO nanowires realized in a single $e$-beam lithography step and with those of YBCO nanowires realized by two $e$-beam steps (where the sides are not protected by Pt/Au), we conclude that the encapsulation is instrumental to achieve rather homogeneous nanostructures when several $e$-beam steps are required. We also show the fundamental role of the ozonation treatment, which for three lithographic step nanowires works to homogenize the nanostructures, healing regions where the superconductivity was previously depressed. The feasibility of our nanogaps to study the proximity-induced Josephson effect in S-N-S junctions is demonstrated by bridging the nanostructure with a thin Au film. We observe Josephson coupling up to 85 K with a Fraunhofer-like magnetic-field dependence. Moreover, conductance measurements on Au/YBCO interfaces also reveal that the heavily underdoped regions, close to the metal-insulator transition, on the side of the nanogap, recover their original doping after ozonation. Our study clearly shows that these YBCO nanogaps can represent a platform for studying new physics in hybrid devices beyond the present state of the art.

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enhanced by a magnetic field, Nat. Nanotechnol. 5, 25 (2010).


[45] The reason for this discrepancy is given by the use at low temperatures of the Ginzburg-Landau theory, which instead is strictly valid only close to the superconducting transition. The calculations for the depairing critical current density in the clean and dirty limit at \( T = 0 \) K predict a deviation from the Ginzburg-Landau limit by a maximum factor of 1.5 [46,47], which reconciles with the higher values of the critical current density extracted on our nanowires after the ozonation.


